Notice of References Cited Application/Control No. 10/015,091 Examiner Brian E. Miller Applicatit(s)/Patent Under' Reexamination HASEGAWA, NAOYA Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,118,621 A	09-2000	Ohsawa et al.	· 360/327
*	В	US-6,744,607 B2	06-2004	Freitag et al.	360/322
*	С	US-2003/0011943 A1	01-2003	Webb et al.	360/324.1
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2000285414 A	10-2000	Japan	KISHI, HITOSHI	G11B 05/39
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
	U							
	V							
	w							
	X							

^{*}A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.